

OFGS P/3255-18 10/500 482

## APPLICANT'S ART CITATION

(Use several sheets if necessary)

Application

Applicant Sylvain DENNIEL et al.

Filing Date

Group Art Unit

## U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate
NC	US-2001/0025664 A1	10-2001	Quigley et al.			
NC	US-5 172 765 A	12-1992	Sas-Jaworsky et al.			
	US-					
	US-					
	US-					
	US-					

## FOREIGN PATENT DOCUMENTS

	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
						Yes	No
NC	WO 86/03362						
NC	2 084 284 A	4-1982	Great Britain				

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

NC		International Search Report

Examiner

Mark A. Long

Date Considered

5/9/06

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